

# SAR TEST REPORT

Reference No.	:	WTS17S0785231E
FCC ID		CCRPXD2
Applicant	:	Sam Ash Music Corporation
Address	211.12	262 Duffy Avenue Hicksville, NY 11801 USA
Manufacturer	St	Sam Ash Music Corporation
Address	:	262 Duffy Avenue Hicksville, NY 11801 USA
Product Name	£ :	Professional Wireless System for Mobile Video
Model No	:	PXD2
Standards	- one	FCC 47 CFR Part2(2.1093) ANSI/IEEE C95.1-2006 IEEE 1528-2013 & KDB 447498 D01 ∨06
Date of Receipt sample	se :	Jul. 22, 2017
Date of Test	:	Jul. 25, 2017
Date of Issue	:	Jul. 27, 2017
Test Result	\$* <u>\</u>	Pass

Remarks:

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## 1 Laboratory Introduction

Waltek Service Co., Ltd. is a professional third-party testing and certification organization with multi-year product testing and certification experience, Established strictly in accordance with ISO/IEC Guide 65 and ISO/IEC 17025, our company has got recognition from <u>CNAS</u> (China National Accreditation Service for Conformity Assessment) and International Laboratory Accreditation Cooperation (ILAC). At the same time, our company has been approved by some authoritative organizations, such as <u>EMSD</u> of Hongkong, UL, Intertek-ETL SEMKO, CSA, MET, TÜV Rheinland, TÜV SÜD, SGS, Nemko, FCC, IC of Canada, <u>CPSC</u>, TMICO and <u>California Energy Commission</u> (CEC). Since the set-up of our company, we sincerely help our customers to improve their products to achieve relative international standards. We are accepted by various clients in international market and well-known in the same industry.



There are several laboratories in our company which are equipped with advanced equipments for fully testing. It can provide testing and certification services for products exported around the world, also it can ensure that the products reach international standards in aspects of safety, electromagnetic compatibility, virulence, energy efficiency, reliability and so on. To enable our customers can get local services more directly and conveniently, and to realize our promise to provide more high quality services. Our company has set up product testing labs in South China and East China (Shenzhen, Dongguan, Foshan, Suzhou and Ningbo). We can provide our clients with accurate test and technical support services in good faith, and actively follow customer demand. These can fully demonstrate Waltek Services concept -- "One-stop Services".

Our company has many experienced engineers and customer service representatives to meet our customer's demand for a number of tests and provide superb technical guidance and modification service; At the same time we can provide global certification services by our global partners to help our customer's products to successfully extend to the global market.



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## 3 Revision History

Test report No.	Date of Receipt sample	Date of Test	Date of Issue	Purpose	Comment	Approved
WTS17S0785231E	Jul. 22, 2017	Jul. 25, 2017	Jul. 27, 2017	original	LIFE WALFER	Valid



## 4 General Information

## 4.1 General Description of E.U.T.

Product Name:	Professional Wireless System for Mobile Video
Model No.:	PXD2
Differences describe	N/A
Frequency range	2406MHz-2478MHz
Number of Channel	25
Channel space	3MHz
Modulation	GFSK
Antenna type	wire antenna
Antenna Gain	-4.5dBi

## 4.2 Details of E.U.T.

Operation Frequency	2406MHz-2478MHz
Max. RF output power	14.76dBm
Max.SAR:	0.48 W/Kg 1g Body-worn Tissue
Technical Data:	DC 3V by 2*1.5V(size "AA" ) batteries

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## 5 INTRODUCTION

## Introduction

This measurement report shows compliance of the EUT with ANSI/IEEE C95.1-2006 and FCC 47 CFR Part2 (2.1093)

The test procedures, as described in IEEE 1528-2013 Standard for IEEE Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques(300MHz~6GHz) and Published RF Exposure KDB Procedures

## **SAR Definition**

- SAR : Specific Absorption Rate
- The SAR characterize the absorption of energy by a quantity of tissue
- This is related to a increase of the temperature of these tissues during a time period.

$$\mathsf{DAS} = \frac{\mathsf{d}}{\mathsf{d}t} \left( \frac{\mathsf{d}W}{\mathsf{d}m} \right) = \frac{\mathsf{d}}{\mathsf{d}t} \left( \frac{\mathsf{d}W}{\rho \mathsf{d}V} \right)$$

$$DAS = c_h \frac{dT}{dt}_{t=0}$$

 $DAS = \frac{\sigma E^2}{\rho}$ 

SAR definition

$$SAR = \frac{\sigma E^2}{\rho}$$

- SAR : Specific Absorption Rate
  - σ : Liquid conductivity

 $o \varepsilon_r = \varepsilon' - j\varepsilon''$  (complex permittivity of liquid)

$$\circ \sigma = \frac{\varepsilon'' \omega}{\varepsilon_0}$$

ρ: Liquid density
 ο ρ = 1000 g/L = 1000Kg/m<sup>3</sup>

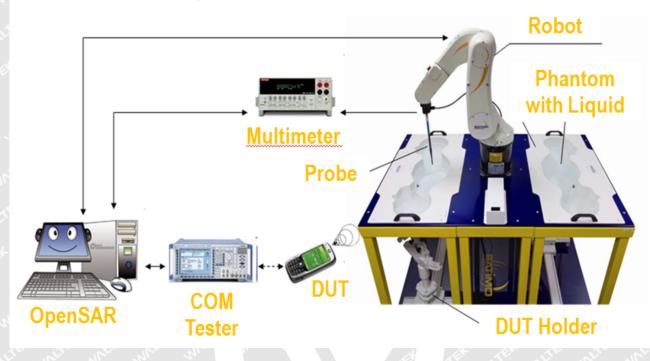
where:

- $\sigma$  = conductivity of the tissue (S/m)
- $\rho$  = mass density of the tissue (kg/m3)
- E = rms electric field strength (V/m)



## 6 SAR MEASUREMENT SETUP

## SAR bench sub-systems



## Scanning System (robot)

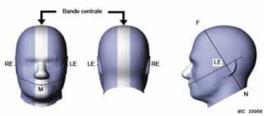
- It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
- Must be able to set the probe orthogonal of the surface of the phantom (±30°).
- Detects stresses on the probe and stop itself if necessary to keep the integrity of the probe.





## SAM Phantom (Specific Anthropomorphic Mannequin)

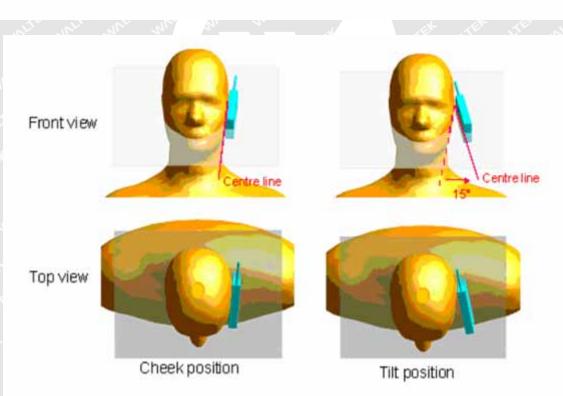
- The probe scanning of the E-Field is done in the 2 half of the normalized head.
- The normalized shape of the phantom corresponds to the dimensions of 90% of an adult head size.
- The materials for the phantom should not affect the radiation of the device under test (DUT)
  - Permittivity < 5</li>
- The head is filled with tissue simulating liquid.
- The hand holding the DUT does not have to be modeled.



Bustration du fantôme donnant les points de référence des oreilles, RE et LE, le point de référence de la bouche, M, la ligne de référence M-F et la bande centrale



Bi-section sagittale du fantônie avec périntêtre étendu (inontrée sur le côté comme lors des essais de DAS de l'appareil)





# The OPENSAR system for performing compliance tests consist of the following items:

- 1. A standard high precision 6-axis robot (KUKA) with controller and software.
- 2. KUKA Control Panel (KCP).
- 3. A dosimetric probe, i.e., an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- 4. The functions of the PC plug-in card are to perform the time critical task such as signal filtering, surveillance of the robot operation fast movement interrupts.
- 5. A computer operating Windows 7.
- 6. OPENSAR software.
- 7. Remote control with teaches pendant and additional circuitry for robot safety such as warning lamps, etc.
- 8. The SAM phantom enabling testing left-hand right-hand and body usage.
- 9. The Position device for handheld EUT.
- 10. Tissue simulating liquid mixed according to the given recipes (see Application Note).
- 11. System validation dipoles to validate the proper functioning of the system.



## Data Evaluation

The OPENSAR software automatically executes the following procedure to calculate the field units from the microvolt readings at the probe connector. The parameters used in the valuation are stored in the configuration modules of the software:

Probe	- Sensitivity	Norm <sub>i</sub>
Parameters	- Conversion factor	ConvFi
white white	- Diode compression point	y tret wifet mifet white white
at at	Dcpi John John John	when we are a start
Device	- Frequency	f at at at at
Parameter	- Crest factor	cf. which where we
Media Parametrs	- Conductivity	on the set set
T didnetis	- Density	P which when we we

These parameters must be set correctly in the software. They can either be found in the component documents or be imported into the software from the configuration files issued for the OPENSAR components.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as

 $V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$ 

Where  $V_i$  = Compensated signal of channel i (i = x, y, z)

- $U_i$  = Input signal of channel i (i = x, y, z)
- cf = Crest factor of exciting field(DASY parameter)

*dcp<sub>i</sub>* = *Diode compression point* (*D*ASY *parameter*)



From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes:

H-field probes:

$$H_{i} = \sqrt{Vi} \cdot \frac{a_{i10} + a_{i11}f + a_{i12}f^{2}}{f}$$

 $E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$ 

Where  $V_i$  = Compensated signal of channel i (i = x, y, z) Norm<sub>i</sub> = Sensor sensitivity of channel i (i = x, y, z)  $\mu V/(V/m)$ 2 for E0field Probes ConvF= Sensitivity enhancement in solution

= Sensor sensitivity factors for H-field probes a<sub>ii</sub>

f = Carrier frequency (GHz)

= Electric field strength of channel i in V/m Ei

= Magnetic field strength of channel i in A/m Hi

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{iii}^{2} \cdot \frac{\sigma}{\rho \cdot 1000}$$
where  $SAR = local specific absorption rate in mW/g$ 

$$E_{tot} = total field strength in V/m$$

$$\sigma = conductivity in [mho/m] or [siemens/m]$$

$$\rho = equivalent tissue density in q/cm3$$

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid.

The power flow density is calculated assuming the excitation field as a free space field.

$$P_{pw} = \frac{E_{xx}^2}{3770}$$
 or  $P_{pw} = H_{xx}^2 \cdot 37.7$ 

where Ppwe = Equivalent power density of a plane wave in mW/cm2

Etot = total electric field strength in V/m

H<sub>tot</sub> = total magnetic field strength in A/m



## SAR Evaluation – Peak Spatial - Average

The procedure for assessing the peak spatial-average SAR value consists of the following steps

#### Power Reference Measurement

The reference and drift jobs are useful jobs for monitoring the power drift of the device under test in the batch process. Both jobs measure the field at a specified reference position, at a selectable distance from the phantom surface. The reference position can be either the selected section's grid reference point or a user point in this section. The reference job projects the selected point onto the phantom surface, orients the probe perpendicularly to the surface, and approaches the surface using the selected detection method.

#### Area Scan

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a finer measurement around the hot spot. The sophisticated interpolation routines implemented in OPENSAR software can find the maximum locations even in relatively coarse grids. The scan area is defined by an editable grid. This grid is anchored at the grid reference point of the selected section in the phantom. When the area scan's property sheet is brought-up, grid was at to 15 mm by 15 mm and can be edited by a user.

#### Zoom Scan

Zoom scans are used to assess the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The default zoom scan measures  $5 \times 5 \times 7$  points within a cube whose base faces are centered around the maximum found in a preceding area scan job within the same procedure. If the preceding Area Scan job indicates more then one maximum, the number of Zoom Scans has to be enlarged accordingly (The default number inserted is 1).

#### Power Drift measurement

The drift job measures the field at the same location as the most recent reference job within the same procedure, and with the same settings. The drift measurement gives the field difference in dB from the reading conducted within the last reference measurement. Several drift measurements are possible for one reference measurement. This allows a user to monitor the power drift of the device under test within a batch process. In the properties of the Drift job, the user can specify a limit for the drift and have OPENSAR software stop the measurements if this limit is exceeded.



## **SAR Evaluation – Peak SAR**

The procedure for spatial peak SAR evaluation has been implemented according to the IEEE1529 standard. It can be conducted for 1 g and 10 g. The OPENSAR system allows evaluations that combine measured data and robot positions, such as:

- maximum search
- extrapolation
- boundary correction
- peak search for averaged SAR

During a maximum search, global and local maximum searches are automatically performed in 2-D after each Area Scan measurement with at least 6 measurement points. It is based on the evaluation of the local SAR gradient calculated by the Quadratic Shepard's method. The algorithm will find the global maximum and all local maxima within -2 dB of the global maxima for all SAR distributions.



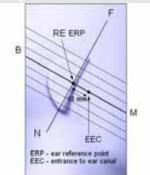
#### Extrapolation

Extrapolation routines are used to obtain SAR values between the lowest measurement points and the inner phantom surface. The extrapolation distance is determined by the surface detection distance and the probe sensor offset. Several measurements at different distances are necessary for the extrapolation. They are used in the Cube Scan to obtain SAR values between the lowest measurement points and the inner phantom surface. The routine uses the fourth order least square polynomial method for extrapolation. For a grid using 5x5x7 measurement points with 5mm resolution amounting to 343 measurement points, the uncertainty of the extrapolation routines is less than 1% for 1 g and 10 g cubes.

#### **Definition of Reference Points**

#### Ear Reference Point

Figure 6.2 shows the front, back and side views of the SAM Phantom. The point "M" is the reference point for the center of the mouth, "LE" is the left ear reference point (ERP), and "RE" is the right ERP. The ERPs are 15mm posterior to the entrance to the ear canal (EEC) along the B-M line (Back-Mouth), as shown in Figure 6.1. The plane passing through the two ear canals and M is defined as the Reference Plane. The line N-F (Neck-Front) is perpendicular to the reference plane and passing through the RE (or LE) is called the Reference Pivoting Line (see Figure 6.1). Line B-M is perpendicular to the N-F line. Both N-F and B-M lines are marked on the external phantom shell to facilitate handset positioning [5].



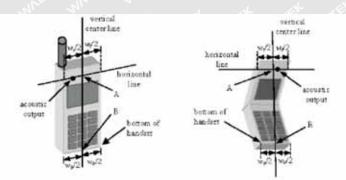
### Figure 6.1 Close-up side view of ERP's



Figure 6.2 Front, back and side view of SAM

#### **Device Reference Points**

Two imaginary lines on the device need to be established: the vertical centerline and the horizontal line. The test device is placed in a normal operating position with the "test device reference point" located along the "vertical centerline" on the front of the device aligned to the "ear reference point" (See Fig. 6.3). The "test device reference point" is than located at the same level as the center of the ear reference point. The test device is positioned so that the "vertical centerline" is bisecting the front surface of the device at it's top and bottom edges, positioning the "ear reference point" on the outer surface of both the left and right head phantoms on the ear reference point [5].



### Figure 6.3 Handset Vertical Center & Horizontal Line Reference Points

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## Test Configuration – Positioning for Cheek / Touch

1. Position the device close to the surface of the phantom such that point A is on the (virtual) extension of the line passing through points RE and LE on the phantom (see Figure below), such that the plane defined by the vertical center line and the horizontal line of the device is approximately parallel to the sagittal plane of the phantom



## Figure 7.1 Front, Side and Top View of Cheek/Touch Position

- 2. Translate the device towards the phantom along the line passing through RE and LE until the device touches the ear.
- 3. While maintaining the device in this plane, rotate it around the LE-RE line until the vertical centerline is in the plane normal to MB-NF including the line MB (called the reference plane).
- 4. Rotate the device around the vertical centerline until the device (horizontal line) is symmetrical with respect to the line NF.
- 5. While maintaining the vertical centerline in the reference plane, keeping point A on the line passing through RE and LE and maintaining the device contact with the ear, rotate the device about the line NF until any point on the device is in contact with a phantom point below the ear (cheek). See Figure below.

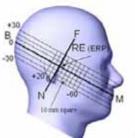


Figure 7.2 Side view w/ relevant markings



## Test Configuration – Positioning for Ear / 15° Tilt

With the test device aligned in the Cheek/Touch Position":

1. While maintaining the orientation of the device, retracted the device parallel to the reference plane far enough to enable a rotation of the device by 15 degrees.

2. Rotate the device around the horizontal line by 15 degrees.

3. While maintaining the orientation of the device, move the device parallel to the reference plane until any part of the device touches the head. (In this position, point A is located on the line RE-LE). The tilted position is obtained when the contact is on the pinna. If the contact is at any location other than the pinna, the angle of the device shall be reduced. The tilted position is obtained when any part of the device is in contact with the ear as well as a second part of the device is in contact with the head (see Figure below).

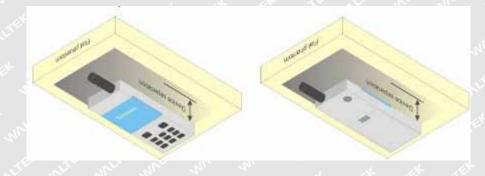


## Figure 7.3 Front, Side and Top View of Ear/15° Tilt Position

## **Test Position – Body Configurations**

Body Worn Position

- (a) To position the device parallel to the phantom surface with either keypad up or down.
- (b) To adjust the device parallel to the flat phantom.
- (c) To adjust the distance between the device surface and the flat phantom to 1.5 cm or holster surface and the flat phantom to 0 cm.





## 7 EXPOSURE LIMIT

In order for users to be aware of the body-worn operating requirements for meeting RF exposure compliance, operating instructions and cautions statements are included in the user's manual.

## **Uncontrolled Environment**

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure. The general population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment-related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

## **Controlled Environment**

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation). In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

#### Table 8.1 Human Exposure Limits

	UNCONTROLLED ENVIRONMENT General Population (W/kg) or (mW/g)	CONTROLLED ENVIROMENT Professional Population (W/kg) or (mW/g)
SPATIAL PEAK SAR <sup>1</sup> Brain	1.60	8.00
SPATIAL AVERAGE SAR <sup>2</sup> Whole Body	0.08	0.40
SPATIAL PEAK SAR <sup>3</sup> Hands, Feet, Ankles, Wrists	4.00	20.00

<sup>1</sup> The Spatial Peak value of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time. <sup>2</sup> The Spatial Average where the set of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

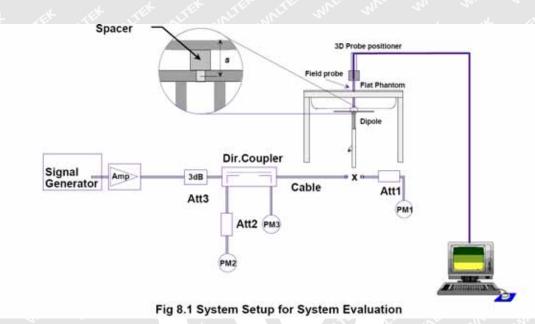
<sup>2</sup> The Spatial Average value of the SAR averaged over the whole body.

<sup>3</sup> The Spatial Peak value of the SAR averaged over any 10 grams of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.



## 8 SYSTEM AND LIQUID VALIDATION

## **System Validation**



The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

In the simplified setup for system evaluation, the DUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:

- 1. Signal Generator
- 2. Amplifier
- 3. Directional Coupler
- 4. Power Meter
- 5. Calibrated Dipole

The output power on dipole port must be calibrated to 30 dBm (1000 mW) before dipole is connected.



# Numerical reference SAR values (W/kg) for reference dipole and flat phantom

Frequency (MHz) 1 g SAR				Local SAR at surface (y = 2 cm offset from feed-point) <sup>a</sup>
300	3.0	2.0	4.4	2.1
450	4.9	3.3	7.2	3.2
835	9.5	6.2	4.1	4.9
900	10.8	6.9	16.4	5.4
1450	29.0	16.0	50.2	6.5
1800	38.1	19.8	69.5	6.8
1900	39.7	20.5	72.1	6.6
2000	41.1	21.1	74.6	6.5
2450	52.4	24.0	104.2	7.7
3000	63.8	25.7	140.2	9.5

## Table 1: system validation (1g)

Ļ	Measurement Date	Frequency (MHz)	Liquid Type (head/body)	1W Target SAR1g (W/kg)	Measured SAR1g (W/kg)	1W Normalized SAR1g (W/kg)	Deviation (%)
Ī	Jul. 25, 2017	2450	body	50.67	0.5140	51.40	1.4
N I			0				

Note: system check input power: 10mW



## Liquid Validation

The dielectric parameters were checked prior to assessment using the HP85070C dielectric probe kit. The dielectric parameters measured are reported in each correspondent section.

## KDB 865664 recommended Tissue Dielectric Parameters

The head and body tissue parameters given in this below table should be used to measure the SAR of transmitters operating in 100 MHz to 6 GHz frequency range. The tissue dielectric parameters of the tissue medium at the test frequency should be within the tolerance required in this document. The dielectric parameters should be linearly interpolated between the closest pair of target frequencies to determine the applicable dielectric parameters corresponding to the device test frequency.

The head tissue dielectric parameters recommended by IEEE Std 1528-2013 have been incorporated in the following table. These head parameters are derived from planar layer models simulating the highest expected SAR for the dielectric properties and tissue thickness variations in a human head. Other head and body tissue parameters that have not been specified in 1528 are derived from tissue dielectric parameters computed from the 4-Cole-Cole equations described above and extrapolated according to the head parameters specified in 1528.

Target Frequency	Head	Tissue	Body	Tissue
MHz	٤r	O' (S/m)	٤r	O' (S/m)
150	52.3	0.76	61.9	0.80
300	45.3	0.87	58.2	0.92
450	43.5	0.87	56.7	0.94
835	41.5	0.90	55.2	0.97
900	41.5	0.97	55.0	1.05
915	41.5	0.98	55.0	1.06
1450	40.5	1.20	54.0	1.30
1610	40.3	1.29	53.8	1.40
1800-2000	40.0	1.40	53.3	1.52
2450	39.2	1.80	52.7	1.95
3000	38.5	2.40	52.0	2.73
5800	35.3	5.27	48.2	6.00



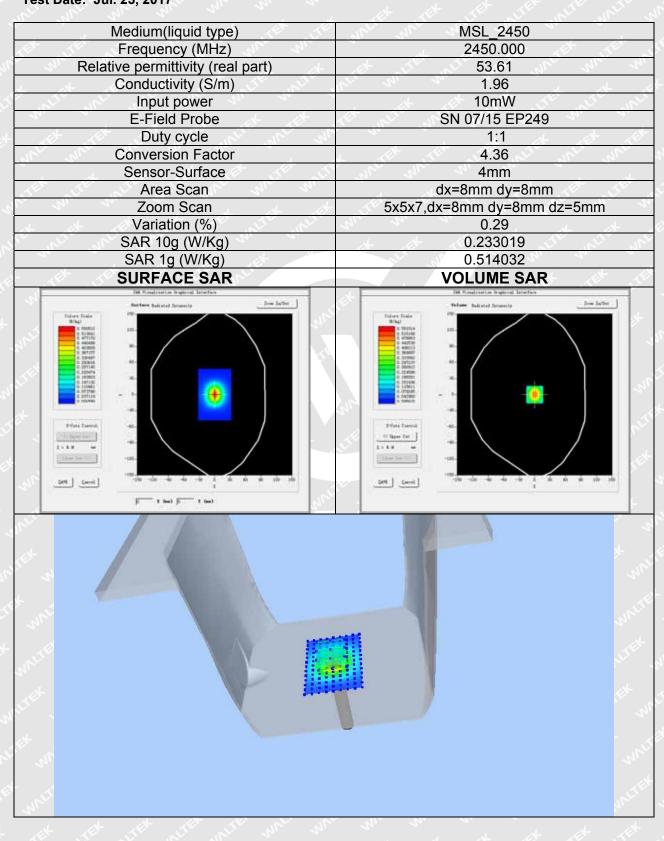
## **Tissue Dielectric Parameters for Head and Body Phantoms**

The head tissue dielectric parameters recommended by the IEEE SCC-34/SC-2 in P1528 have been incorporated in the following table. These head parameters are derived from planar layer models simulating the highest expected SAR for the dielectric properties and tissue thickness Power drifts in a human head. Other head and body tissue parameters that have not been specified in P1528 are derived from the tissue dielectric parameters computed from the 4-Cole-Cole equations described in Reference [12] and extrapolated according to the head parameters specified in P1528.

	Table	Table 2: Dielectric Performance of Body Tissue Simulating Liquid						
	Temperature: 21°C	C, Relative humidity	:57%, Measured Date: Ju	ul 25,2017				
	Frequency(MHz) Measured Date	Massurad Data	Description	Dielectric Parameters				
		Description	٤r	σ(s/m)				
	t it		Target Value	52.70	1.95			
	2450	Jul. 25, 2017	±5% window	50.07 — 55.33	1.86 — 2.04			
	24 2.	4	Measurement Value	53.61	1.96			



System Verification Plots Product Description: Dipole Model: SID2450 Test Date: Jul. 25, 2017



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## 9 TYPE A MEASUREMENT UNCERTAINTY

The component of uncertainly may generally be categorized according to the methods used to evaluate them. The evaluation of uncertainly by the statistical analysis of a series of observations is termed a Type An evaluation of uncertainty. The evaluation of uncertainty by means other than the statistical analysis of a series of observation is termed a Type B evaluation of uncertainty. Each component of uncertainty, however evaluated, is represented by an estimated standard deviation, termed standard uncertainty, which is determined by the positive square root of the estimated variance

A Type A evaluation of standard uncertainty may be based on any valid statistical method for treating data. This includes calculating the standard deviation of the mean of a series of independent observations; using the method of least squares to fit a curve to the data in order to estimate the parameter of the curve and their standard deviations; or carrying out an analysis of variance in order to identify and quantify random effects in certain kinds of measurement.

A type B evaluation of standard uncertainty is typically based on scientific judgment using all of the relevant information available. These may include previous measurement data, experience and specification, data provided in calibration reports and uncertainties assigned to reference data taken from handbooks. Broadly speaking, the uncertainty is either obtained from an outdoor source or obtained from an assumed distribution, such as the normal distribution, rectangular or triangular distributions indicated in Table below :

Uncertainty Distribution	Normal	Rectangle	Triangular	U Shape
Multi-plying Factor <sup>(a)</sup>	1/k <sup>(b)</sup>	1/\3	1/√6	1/√2

(a) standard uncertainty is determined as the product of the multiplying factor and the estimated range of variations in the measured quantity
 (b) κ is the coverage factor

Standard Uncertainty for Assumed Distribution

The combined standard uncertainty of the measurement result represents the estimated standard deviation of the result. It is obtained by combining the individual standard uncertainties of both Type A and Type -sumby taking the positive square root of the estimated variances.

Expanded uncertainty is a measure of uncertainty that defines an interval about the measurement result within which the measured value is confidently believed to lie. It is obtained by multiplying the combined standard uncertainty by a coverage factor. Typically, the coverage factor ranges from 2 to 3. Using a coverage factor allows the true value of a measured quantity to be specified with a defined probability within the specified uncertainty range. For purpose of this document, a coverage factor two is used, which corresponds to confidence interval of about 95 %.

The COMOSAR Uncertainty Budget is show in below table:

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## UNCERTAINTY FOR SYSTEM PERFORMANCE CHECK

Uncertainty Component	Tol. (± %)	Prob. Dist.	Div.	ci (1 g)	ci (10 g)	1 g ui (± %)	10 g ui (± %)	N <sup>1</sup> vi vi
Measurement System								
Probe Calibration	5,8	N	1.+	1	1	5,8	5,8	~
Axial Isotropy	3,5	R	√3	(1- cp)1/2	(1- cp)1/2	1,42887	1,42887	×
Hemispherical Isotropy	5,9	R	√√3	√Ср	√Cp	2,40866	2,40866	∞
Boundary Effect	1,1	R	√3	1	1	0,57735	0,57735	∞
Linearity	4,7	R	√3	1	<u>ک</u> 1 ک	2,71355	2,71355	<b>√</b> ∞
System Detection Limits	1	R	√3	- 10 <sup>1</sup>	1	0,57735	0,57735	∞
Readout Electronics	0,5	-∽N	1	1	1 🗸	0,5	0,5	∞
Response Time	0	R	√3 <	1.1	1	01	v 0 v	
Integration Time	1,4	R	√3	~1	1	0,80829	0,80829	~ ~ ~
RF Ambient Conditions	3	R	√3	1.	1	1,73205	1,73205	
Probe Positioner Mechanical Tolerance	1,4	R	√3	1	<sup>110</sup> 1	0,80829	0,80829	~
Probe Positioning with respect to Phantom Shell	1,4	R	√3	JJ161	1,00	0,80829	0,80829	w w
Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	2,3	R	√3	( <sup>3</sup> 1	3155	1,32791	1,32791	MALIE N
Dipole								
Dipole Axis to Liquid Distance	2	N	√3	1	1	1,1547	1,1547	N-1
Input Power and SAR drift measurement	5	R	√3	3	1-	2,88675	2,88675	
Phantom and Tissue Parameters								
Phantom Uncertainty (shape and thickness tolerances)	4	R	√3	1	<u>_</u> _1	2,3094	2,3094	∞ <sup>ric</sup>
Liquid Conductivity - deviation from target values	5	R	√3	0,64	0,43	1,84752	1,2413	°
Liquid Conductivity - measurement uncertainty	4	N	1.1	0,64	0,43	2,56	1,72	М
Liquid Permittivity - deviation from target values	5	R	√3	0,6	0,49	1,73205	1,41451	@ \\\
Liquid Permittivity - measurement uncertainty	5 1	N	1	0,6	0,49	1 <sup>-1-3</sup>	2,45	М
Combined Standard Uncertainty		RSS		n' n'		9.6671	9.1646	
Expanded Uncertainty (95% CONFIDENCE INTERVAL)	m	k	*	(1+ J	et ju	19.3342	18.3292	WALTER



## **UNCERTAINTY EVALUATION FOR HANDSET SAR TEST**

Uncertainty Component	Tol. (± %)	Prob. Dist.	Div.	c <sub>i</sub> (1 g)	c <sub>i</sub> (10 g)	1 g u <sub>i</sub> (± %)	10 g u <sub>i</sub> (± %)	VILLE Vi
Measurement System				L				
Probe Calibration	5,8	N	1	1	<u>1</u>	5,8	5,8	∞
Axial Isotropy	3,5	R	√3	$(1-c_p)^{1/2}$	$(1-c_p)^{1/2}$	1,43	(1,43	∞
Hemispherical Isotropy	5,9	R	√3	√C <sub>p</sub>	√C <sub>p</sub>	2,41	2,41	∞
Boundary Effect	<u>1</u> 11	R	√3	1	1	0,58	0,58	∞
Linearity	4,7	R	√3	1	<u>د ا</u>	2,71	2,71	<u>∽</u> ~ ∞
System Detection Limits	1,5	R	√3	1.1	1	0,58	0,58	8
Readout Electronics	0,5	<i>∽</i> N	1	1	- 1, ,+	0,50	0,50	8
Response Time	0	R	√3	1	1	0,00	0,00	8
Integration Time	1,4	R	√3	1	1	0,81	0,81	× ∞
RF Ambient Conditions	3	R	√3	1	1	1,73	1,73	8
Probe Positioner Mechanical Tolerance	1,4	R	√3	1	<sup>311</sup> 1 <sup>35</sup>	0,81	0,81	st ∞, jt
Probe Positioning with respect to Phantom Shell	1,4	R	√3	NUTER 1	1.00	0,81	0,81	8
Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	2,3	R	√3	a <sup>r</sup> 1	1.1.TE	1,33	1,33	₩1.1 ∞
Test sample Related				_				
Test Sample Positioning	2,6	N	1	1	1	2,60	2,60	N-1
Device Holder Uncertainty	3	N	1	1	1	3,00	3,00	✓ N-1
Output Power Variation - SAR drift measurement	5	R	√3	1 5	NUT N	2,89	2,89	8
Phantom and Tissue Parameters								
Phantom Uncertainty (shape and thickness tolerances)	4	R	√3		11/11	2,31	2,31	8
Liquid Conductivity - deviation from target values	5	R	√3	0,64	0,43	1,85	1,24	M <sup>∞</sup> M
Liquid Conductivity - measurement uncertainty	4	N	1	0,64	0,43	2,56	1,72	M
Liquid Permittivity - deviation from target values	5 5	R	√3	0,6	0,49	1,73	1,41	or ∞, rik
Liquid Permittivity - measurement uncertainty	5 J	N N N	1	0,6 🗸	0,49	3,00	2,45	М
Combined Standard Uncertainty		RSS	*	at a	et 11	10.39	9.92	with s
Expanded Uncertainty (95% CONFIDENCE INTERVAL)	NNLTER	_√k <sup>11</sup>	-nn	MUT	- nn-	20.78	19.84	. et .



## 10<u>TEST INSTRUMENT</u>

Name of Equipment	Manufacturer	Type/Mod el	Serial Number	Calibratio n Date	Calibration Due	
6 AXIS ROBOT	KUKA	KR6 R900 SIXX	502635	N/A	N/A	
SATIMO Test Software	MVG	OPENSAR	OPENSAR V_4_02_27	N/A	S N/A	
PHANTOM TABLE	MVG	N/A	SAR_1215_01	N/A	N/A	
SAM PHANTOM	MVG	SAM118	SN 11/15 SAM118	N/A	N/A V	
MultiMeter	Keithley	MiltiMeter 2000	4073942	2017-03-16	2018-03-15	
Data Acquisition Electronics	MVG	DAE4	915	2017-03-16	2018-03-15	
S-Parameter Network Analyzer	Agilent	8753E	JP38160684	2016-09-12	2017-09-11	
Universal Radio Communication Tester	Universal Radio Communication W AR7		112461	2016-09-12	2017-09-11	
E-Field Probe	MVG	SSE5	SN 07/15 EP249	2016-09-23	2017-09-22	
DIPOLE 2450	MVG	SID2450	SN 09/15 DIP 2G450-363	2015-03-16	2018-03-15	
Limesar Dielectric Probe			SN 11/15 OCPG 69	2016-03-16	2018-03-15	
Power Amplifier	BONN	BLWA 0830 -160/100/40D	128740	2016-09-12	2017-09-11	
Signal Generator	R&S	SMB100A	105942	2016-09-12	2017-09-11	
Power Meter	R&S	NRP2	102031	2016-09-12	2017-09-11	



## **11<u>OUTPUT POWER VERIFICATION</u>**

#### Test Condition:

- 1. Conducted Measurement EUT was set for low, mid, high channel with modulated mode and highest RF output power. The base station simulator was connected to the antenna terminal. 2 Conducted Emissions Measurement Uncertainty All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz - 40GHz is ±1.5dB. 3 **Environmental Conditions** Temperature 23°C Relative Humidity 53% Atmospheric Pressure 1019mbar 4 Test Date : Jul. 25, 2017
- Tested By : Andy Feng

#### **Test Procedures:**

According to KDB 447498 D01v06, when the frequency channels required for SAR testing are not specified in the published RF exposure KDB procedures, the following should be applied to determine the number of required test channel. The test channel should be evenly spread across the transmission frequency band of each wireless mode.

$$N_{\rm c} = Round \left\{ \left[ 100 (f_{\rm high} - f_{\rm low}) / f_{\rm c} \right]^{0.5} \times (f_{\rm c} / 100)^{0.2} \right\},\$$

#### where

- N<sub>c</sub> is the number of test channels, rounded to the nearest integer,
- f<sub>high</sub> and f<sub>low</sub> are the highest and lowest channel frequencies within the transmission band,
- *f*<sub>c</sub> is the mid-band channel frequency,
- all frequencies are in MHz.

## **Test Result:**

	Mode	Frequency (MHz)	Output Power(dBm)	Tune up limited(dBm)	
	mur mur a	2406	14.76	14±1	
L.	FHSS	2442	14.76	14±1	
10	NITE WALL WALL V	2478	13.79	14±1	

Note: When the measured SAR for middle channel is less than 0.6W/Kg, and the transmission band is between 100MHz and 200MHz, other channels are not required.



## 12 EXPOSURE CONDITIONS CONSIDERATION

## EUT antenna location:



Note:

- 1. Body-worn SAR assessments are required.
- 2. No WIFI mode, Hotpot SAR is not required.
- 3. Per KDB 447498 D01v06, for handsets the test separation distance is determined by the smallest distance between the outer surface of the device and the user, which is 0 mm for body-worn SAR.



## 13SAR TEST RESULTS

#### **Test Condition:**

- 1. SAR Measurement The distance between the EUT and the antenna of the emulator is more than 50 cm and the output power radiated from the emulator antenna is at least 30 dB less than the output power of EUT.
- 2 Environmental Conditions
   3 Test Date : Jul. 25, 2017 Tested By : Andy Feng
   Temperature Relative Humidity Atmospheric Pressure

#### **Test Procedures:**

- 1. Establish communication link between EUT and base station emulation by air link.
- Consider the SAR test reduction per FCC KDB guide line. For FHSS, set EUT into highest output power channel with test mode which has the maximum source-based timeaveraged burst power listed in power table.

23°C

57%

1019mbar

- 3. Place the EUT in the selected test position.
- 4. Perform SAR testing at highest output power channel under the selected test mode. If the measured 1-g SAR is ≤ 0.8 W/kg, then testing for the other channel will not be performed.
- 5. When SAR is<0.8W/kg, no repeated SAR measurement is required
- SAR measurement system will proceed the following basic steps:
  - 1. Initial power reference measurement
  - 2. Area Scan
  - 3. Zoom Scan
  - 4. Power drift measurement



## SAR Summary Test Result:

Test	Ch	Channel Powe		er(dBm)	SAR 1g( Limit(1.6	Plot	
Positions	СН.	MHz	Maximum Turn-up Power(dBm)	Measured output power(dBm)	Measured SAR 1g(W/kg)	Scaled SAR 1g(W/kg)	No.
	Low	2406	15	14.76	0.456	0.48	<sup>3</sup> 1
Body-worn	Mid	2442	15 🕔	14.76	0.454	0.48	<u>_</u> 2
	High	2478	15	13.79	0.224	0.30	3 <

## Table 3: SAR Values of FHSS

#### Measurement variability consideration

According to KDB 865664 D01v01r04 section 2.8.1, repeated measurements are required following the procedures as below:

- Repeated measurement is not required when the original highest measured SAR is < 0.80W/kg; steps 2) through 4) do not apply.</li>
- 2. When the original highest measured SAR is  $\geq$  0.80 W/kg, repeat that measurement once.
- 3. Perform a second repeated measurement only if the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20 or when the original or repeated measurement is ≥ 1.45 W/kg (~ 10% from the 1-g SAR limit).
- Perform a third repeated measurement only if the original, first or second repeated measurement is ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20.

No repeated SAR.



## 14SAR MEASUREMENT REFERENCES

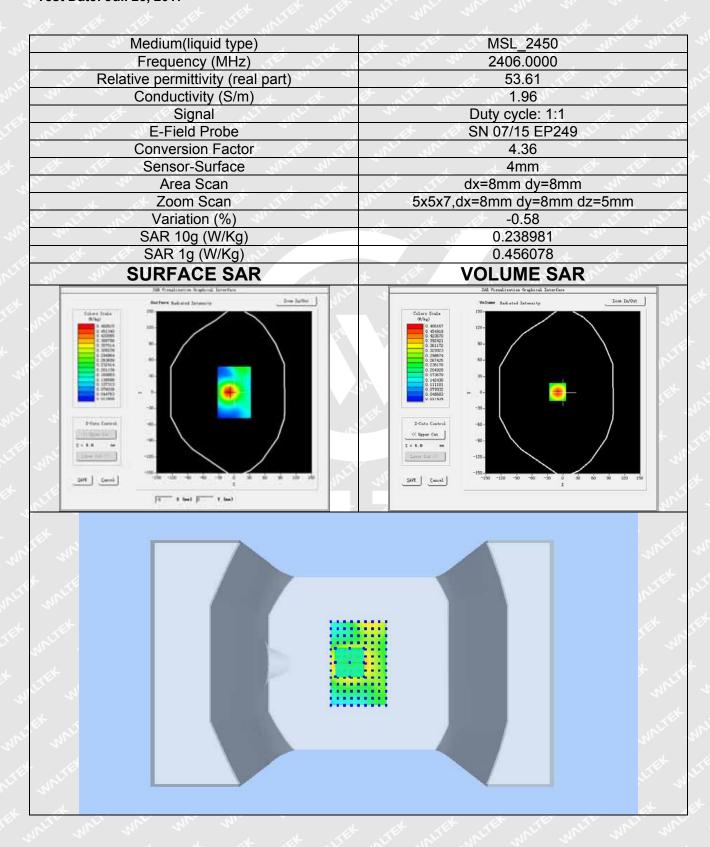
## References

- 1. FCC 47 CFR Part 2 "Frequency Allocations and Radio Treaty Matters; General Rules and Regulations"
- 2. IEEE Std. C95.1-2005, "IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3kHz to 300GHz", 2005
- 3. IEEE Std. 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices:Measurement Techniques", June 2013
- 4. IEC 62209-2, "Human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices—Human models, instrumentation, and procedures – Part 2: Procedure to determine the specific absorption rate(SAR) for wireless communication devices used in close proximity to the human body(frequency range of 30MHz to 6GHz)", April 2010
- 5. FCC KDB 447498 D01 v06, "Mobile and Portable Device RF Exposure Procedures and Equipment Authorization Policies", Oct 23<sup>th</sup>, 2015
- FCC KDB865664 D01 v01r04, "SAR Measurement Requirements 100MHz to 6GHz", Aug 7<sup>th</sup>, 2015
- FCC KDB865664 D02 v01r02, "RF Exposure Compliance Reporting and Documentation Considerations ", Oct 23<sup>th"</sup>, 2015
- 8. FCC KDB648474 D04 v01r03, "SAR Evaluation Considerations for Wireless Handsets", Oct 23<sup>th"</sup>, 2015



## **SAR measurement Plots**

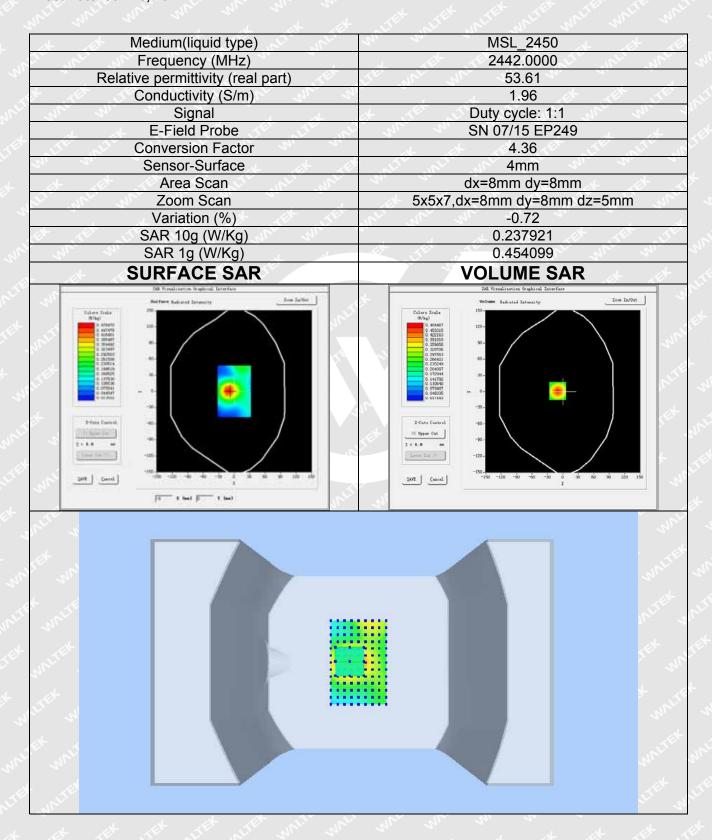
Plot 1: Low channel (Body-worn, Back side) Product Description:Professional Wireless System for Mobile Video Model: PXD2 Test Date: Jul. 25, 2017



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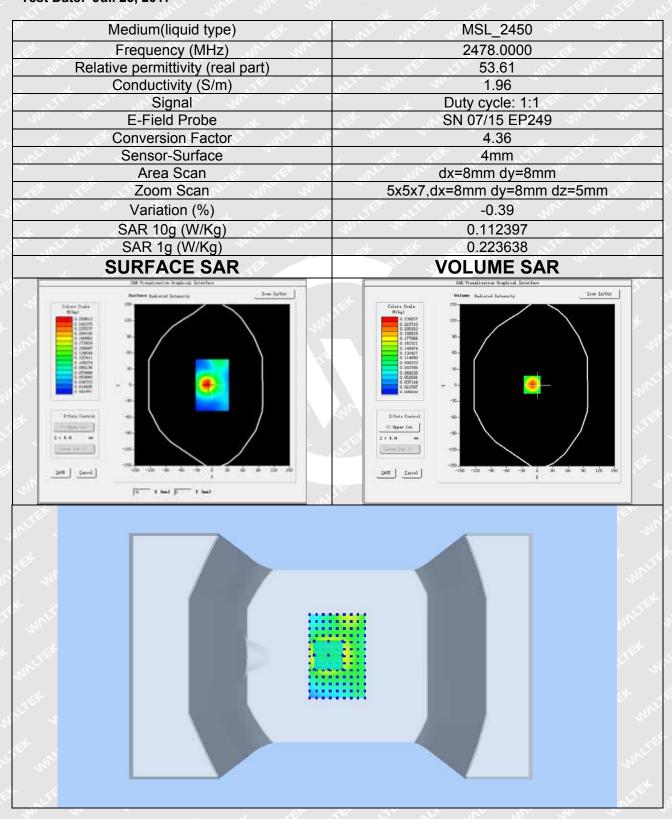
#### Plot 2: Middle channel (Body-worn, Back side) Product Description:Professional Wireless System for Mobile Video Model:PXD2 Test Date: Jul. 25, 2017



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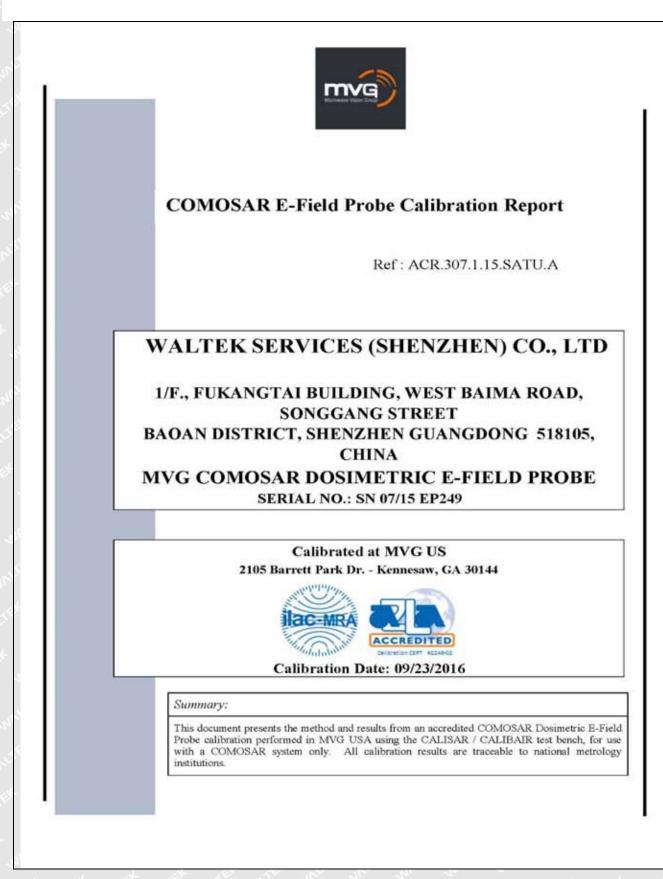
#### Plot 3: High channel (Body-worn, Back side) Product Description: Professional Wireless System for Mobile Video Model: PXD2 Test Date: Jul. 25, 2017



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## 15 Calibration reports-Probe



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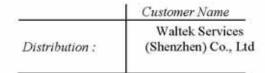




COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR 307.1.15 SATU A

	Name	Function	Date	Signature
Prepared by :	Jérôme LUC	Product Manager	10/5/2016	JS
Checked by :	Jérôme LUC	Product Manager	10/5/2016	JS
Approved by :	Kim RUTKOWSKI	Quality Manager	10/5/2016	Him Authoushi



Date	Modifications
10/5/2016	Initial release

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Ref: ACR 307.1.15 SATU A

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1

COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR 307.1.15 SATU A

### DEVICE UNDER TEST

Device Under Test				
Device Type COMOSAR DOSIMETRIC E FIELD PRO				
Manufacturer	MVG			
Model	SSE5			
Serial Number	SN 07/15 EP249			
Product Condition (new / used)	Used			
Frequency Range of Probe	0.7 GHz-3GHz			
Resistance of Three Dipoles at Connector	Dipole 1: R1=0.180 MΩ			
	Dipole 2: R2=0.191 MΩ			
	Dipole 3: R3=0.179 MΩ			

A yearly calibration interval is recommended.

# 2 PRODUCT DESCRIPTION

### 2.1 GENERAL INFORMATION

MVG's COMOSAR E field Probes are built in accordance to the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards.



Figure 1 – MVG COMOSAR Dosimetric E field Dipole

Probe Length	330 mm
Length of Individual Dipoles	4.5 mm
Maximum external diameter	8 mm
Probe Tip External Diameter	5 mm
Distance between dipoles / probe extremity	2.7 mm

#### 3 MEASUREMENT METHOD

The IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards provide recommended practices for the probe calibrations, including the performance characteristics of interest and methods by which to assess their affect. All calibrations / measurements performed meet the fore mentioned standards.

# 3.1 LINEARITY

The evaluation of the linearity was done in free space using the waveguide, performing a power sweep to cover the SAR range 0.01W/kg to 100W/kg.

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### 3.2 SENSITIVITY

The sensitivity factors of the three dipoles were determined using a two step calibration method (air and tissue simulating liquid) using waveguides as outlined in the standards.

#### 3.3 LOWER DETECTION LIMIT

The lower detection limit was assessed using the same measurement set up as used for the linearity measurement. The required lower detection limit is 10 mW/kg.

#### 3.4 ISOTROPY

The axial isotropy was evaluated by exposing the probe to a reference wave from a standard dipole with the dipole mounted under the flat phantom in the test configuration suggested for system validations and checks. The probe was rotated along its main axis from 0 - 360 degrees in 15 degree steps. The hemispherical isotropy is determined by inserting the probe in a thin plastic box filled with tissue-equivalent liquid, with the plastic box illuminated with the fields from a half wave dipole. The dipole is rotated about its axis (0°-180°) in 15° increments. At each step the probe is rotated about its axis (0°-360°).

#### 3.5 BOUNDARY EFFECT

The boundary effect is defined as the deviation between the SAR measured data and the expected exponential decay in the liquid when the probe is oriented normal to the interface. To evaluate this effect, the liquid filled flat phantom is exposed to fields from either a reference dipole or waveguide. With the probe normal to the phantom surface, the peak spatial average SAR is measured and compared to the analytical value at the surface.

#### 4 MEASUREMENT UNCERTAINTY

The guidelines outlined in the IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty associated with an E-field probe calibration using the waveguide technique. All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

Uncertainty analysis of the probe calibration in waveguide						
ERROR SOURCES	Uncertainty value (%)	Probability Distribution	Divisor	ci	Standard Uncertainty (%)	
Incident or forward power	3.00%	Rectangular	$\sqrt{3}$	1	1.732%	
Reflected power	3.00%	Rectangular		1	1.732%	
Liquid conductivity	5.00%	Rectangular		1	2.887%	
Liquid permittivity	4.00%	Rectangular		1	2.309%	
Field homogeneity	3.00%	Rectangular	\sqrt{3}	1	1.732%	
Field probe positioning	5.00%	Rectangular	$\sqrt{3}$	1	2.887%	

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Field probe linearity	3.00%	Rectangular	√3	1	1.732%
Combined standard uncertainty					5.831%
Expanded uncertainty 95 % confidence level k = 2					12.0%

# 5 CALIBRATION MEASUREMENT RESULTS

Calibration Parameters				
Liquid Temperature	21 °C			
Lab Temperature	21 °C			
Lab Humidity	45 %			

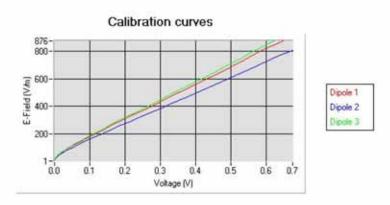
# 5.1 SENSITIVITY IN AIR

		Normz dipole 3 (µV/(V/m) <sup>2</sup> )
6.91	7.46	6.48

DCP dipole 1	DCP dipole 2	DCP dipole 3
(mV)	(mV)	(mV)
97	93	94

Calibration curves ei=f(V) (i=1,2,3) allow to obtain H-field value using the formula:

$$E = \sqrt{E_1^2 + E_2^2 + E_3^2}$$

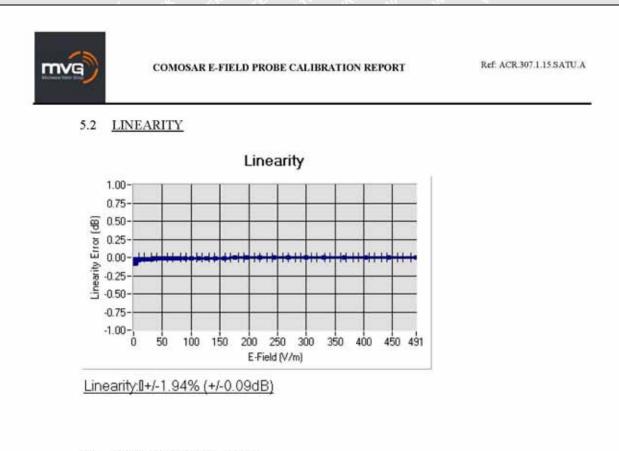


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# 5.3 SENSITIVITY IN LIQUID

Liquid	Frequency (MHz +/- 100MHz)	Permittivity	Epsilon (S/m)	<u>ConvF</u>
HL750	750	41.82	0.90	4.74
BL750	750	56.28	0.98	4.85
HL850	835	42.59	0.90	5.05
BL850	835	53.19	0.97	5.22
HL900	900	42.05	0.98	4.82
BL900	900	56.41	1.08	4.99
HL1800	1800	41.82	0.38	4.21
BL1800	1800	53.00	1.52	4.33
HL1900	1900	40.38	1.41	4.86
BL1900	1900	53.93	1.55	5.05
HL2000	2000	40.12	1.43	4.37
BL2000	2000	53.65	1.54	4.51
HL2450	2450	38.34	1.80	4.21
BL2450	2450	52.70	1.94	4.36
HL2600	2600	38.16	1.93	4.18
BL2600	2600	51.55	2.21	4.31

#### LOWER DETECTION LIMIT: 7mW/kg

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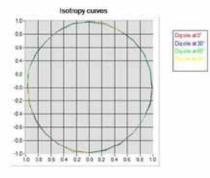
Ref: ACR 307.1.15 SATU.A

#### 5.4 ISOTROPY

### HL900 MHz

- Axial i	sotropy:	S
- Hemisy	oherical	isotropy:

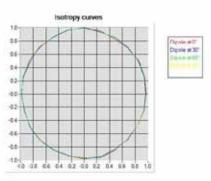
0.04 dB 0.05 dB



### HL1800 MHz

- Axial isotropy:	
- Hemispherical isotropy:	

0.04 dB 0.07 dB



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Ref: ACR 307.1.15 SATU A

# 6 LIST OF EQUIPMENT

Equipment Summary Sheet						
Equipment Description	Manufacturer / Model	Identification No.	Current Calibration Date	Next Calibration Date		
Flat Phantom	MVG	SN-20/09-SAM71	Validated. No cal required.	Validated. No ca required.		
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No ca required.		
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2016	02/2019		
Reference Probe	MVG	EP 94 SN 37/08	10/2015	10/2016		
Multimeter	Keithley 2000	1188656	12/2013	12/2016		
Signal Generator	Agilent E4438C	MY49070581	12/2013	12/2016		
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.		
Power Meter	HP E4418A	US38261498	12/2013	12/2016		
Power Sensor	HP ECP-E26A	US37181460	12/2013	12/2016		
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.		
Waveguide	Mega Industries	069Y7-158-13-712	Validated. No cal required.	Validated. No cal required.		
Waveguide Transition	Mega Industries	069Y7-158-13-701	Validated. No cal required.	Validated. No cal required.		
Waveguide Termination	Mega Industries	069Y7-158-13-701	Validated. No cal required.	Validated. No cal required.		
Temperature / Humidity Sensor	Control Company	11-661-9	8/2015	8/2018		

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Reference No.: WTS17S0785231E

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# **SAR Reference Dipole Calibration Report**

Ref : ACR.92.8.15.SATU.A

WALTEK SERVICES (SHENZHEN) CO., LTD 1/F., FUKANGTAI BUILDING, WEST BAIMA ROAD, SONGGANG STREET BAOAN DISTRICT, SHENZHEN GUANGDONG 518105, CHINA

# MVG COMOSAR REFERENCE DIPOLE

FREQUENCY: 2450 MHZ SERIAL NO.: SN 09/15 DIP 2G450-363

Calibrated at MVG US 2105 Barrett Park Dr. - Kennesaw, GA 30144



Summary:

This document presents the method and results from an accredited SAR reference dipole calibration performed in MVG USA using the COMOSAR test bench. All calibration results are traceable to national metrology institutions.

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Ref: ACR.92.8.15.SATU.A

	Name	Function	Date	Signature
Prepared by :	Jérôme LUC	Product Manager	4/2/2015	JES
Checked by :	Jérôme LUC	Product Manager	4/2/2015	JS
Approved by :	Kim RUTKOWSKI	Quality Manager	4/2/2015	Him Buthnishi

	Customer Name
Distribution :	Waltek Services (Shenzhen) Co., Ltd

Issue	Date	Modifications
A	4/2/2015	Initial release

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SAR REFERENCE DIPOLE CALIBRATION REPORT

Ref: ACR.92.8.15.SATU.A

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# 1 INTRODUCTION

This document contains a summary of the requirements set forth by the IEEE 1528, FCC KDBs and CEI/IEC 62209 standards for reference dipoles used for SAR measurement system validations and the measurements that were performed to verify that the product complies with the fore mentioned standards.

# 2 DEVICE UNDER TEST

Device Under Test				
Device Type	COMOSAR 2450 MHz REFERENCE DIPOLE			
Manufacturer	MVG			
Model	SID2450			
Serial Number	SN 09/15 DIP 2G450-363			
Product Condition (new / used) New				

A yearly calibration interval is recommended.

# 3 PRODUCT DESCRIPTION

# 3.1 GENERAL INFORMATION

MVG's COMOSAR Validation Dipoles are built in accordance to the IEEE 1528, FCC KDBs and CEI/IEC 62209 standards. The product is designed for use with the COMOSAR test bench only.



Figure 1 – MVG COMOSAR Validation Dipole

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#### 4 MEASUREMENT METHOD

The IEEE 1528, FCC KDBs and CEI/IEC 62209 standards provide requirements for reference dipoles used for system validation measurements. The following measurements were performed to verify that the product complies with the fore mentioned standards.

#### 4.1 RETURN LOSS REQUIREMENTS

The dipole used for SAR system validation measurements and checks must have a return loss of -20 dB or better. The return loss measurement shall be performed against a liquid filled flat phantom, with the phantom constucted as outlined in the fore mentioned standards.

#### 4.2 MECHANICAL REQUIREMENTS

The IEEE Std. 1528 and CEI/IEC 62209 standards specify the mechanical components and dimensions of the validation dipoles, with the dimensions frequency and phantom shell thickness dependent. The COMOSAR test bench employs a 2 mm phantom shell thickness therefore the dipoles sold for use with the COMOSAR test bench comply with the requirements set forth for a 2 mm phantom shell thickness.

#### 5 MEASUREMENT UNCERTAINTY

All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

#### 5.1 RETURN LOSS

The following uncertainties apply to the return loss measurement:

Frequency band	Expanded Uncertainty on Return Loss
400-6000MHz	0.1 dB

#### 5.2 DIMENSION MEASUREMENT

The following uncertainties apply to the dimension measurements:

Length (mm)	Expanded Uncertainty on Length		
3 - 300	0.05 mm		

#### 5.3 VALIDATION MEASUREMENT

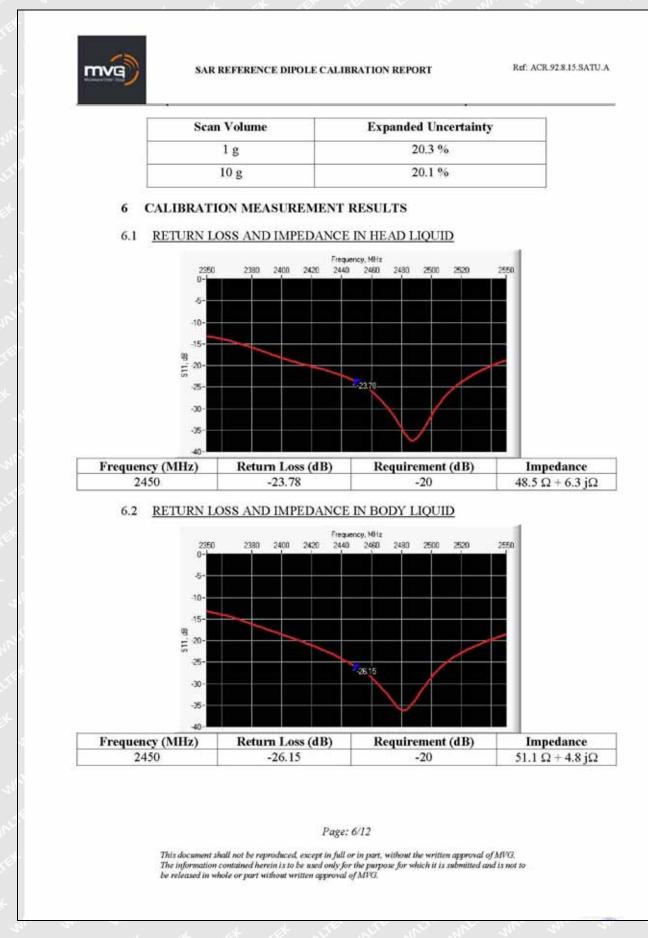
The guidelines outlined in the IEEE 1528, FCC KDBs, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty for validation measurements.

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Frequency MHz	Ln	Lmm		hmm		nm
	required	measured	required	measured	required	measured
300	420.0 ±1 %.		250.0±1%.		6.35 ±1 %	
450	290.0 ±1 %.		166.7±1%.		6.35 ±1 %.	
750	176.0±1 %.		100.0 ±1 %.		6.35±1 %	
835	161.0 ±1 %.		89.8 ±1 %.		3.6 ±1 %.	
900	149.0 ±1 %.		83.3 ±1 %.		3.6 ±1 %.	
1450	89.1 ±1 %.		51.7 ±1 %.		3.6 ±1 %.	
1500	80.5 ±1 %.		50.0 ±1 %.		3.6 ±1 %.	
1640	79.0 ±1 %.		45.7 ±1 %.		3.6 ±1 %.	
1750	75.2 ±1 %.		42.9 ±1 %.		3.6 ±1 %.	
1800	72.0 ±1 %.		41.7 ±1 %.		3.6 ±1 %.	
1900	68.0 ±1 %.		39.5 ±1 %.		3.6 ±1 %.	
1950	66.3 ±1 %.		38.5 ±1 %.		3.6 ±1 %.	
2000	64.5 ±1 %.		37.5 ±1 %.		3.6 ±1 %.	
2100	61.0 ±1 %.		35.7 ±1 %.		3.6 ±1 %.	
2300	55.5 ±1 %.		32.6 ±1 %.		3.6 ±1 %.	
2450	51.5 ±1 %.	PASS	30.4 ±1 %	PASS	3.6 ±1 %	PASS
2600	48.5 ±1 %.		28.8 ±1 %.		3.6±1%.	
3000	41.5 ±1 %.		25.0 ±1 %.		3.6 ±1 %.	
3500	37.0±1 %.		26.4 ±1 %.		3.6 ±1 %.	
3700	34.7±1 %.		26.4 ±1 %.		3.6 ±1 %.	

#### 6.3 MECHANICAL DIMENSIONS

#### 7 VALIDATION MEASUREMENT

The IEEE Std. 1528, FCC KDBs and CEI/IEC 62209 standards state that the system validation measurements must be performed using a reference dipole meeting the fore mentioned return loss and mechanical dimension requirements. The validation measurement must be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards. Per the standards, the dipole shall be positioned below the bottom of the phantom, with the dipole length centered and parallel to the longest dimension of the flat phantom, with the top surface of the dipole at the described distance from the bottom surface of the phantom.

#### 7.1 HEAD LIQUID MEASUREMENT

Frequency MHz	Relative per	mittivity (ɛ,')	Conductiv	ity (a) S/m
	required	measured	required	measured
300	45.3 ±5 %		0.87±5%	
450	43.5 ±5 %		0.87±5%	

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750	41.9 ±5 %		0.89 ±5 %	
835	41.5 ±5 %		0.90±5%	
900	41.5 ±5 %		0.97±5%	
1450	40.5 ±5 %		1.20±5 %	
1500	40.4 ±5 %		1.23±5%	
1640	40.2 ±5 %		1.31±5%	
1750	40.1 ±5 %		1.37±5%	
1800	40.0 ±5 %		1.40 ±5 %	
1900	40.0 ±5 %		1.40±5%	
1950	40.0 ±5 %		1.40±5%	
2000	40.0 ±5 %		1.40±5%	
2100	39.8 ±5 %		1.49 ±5 %	
2300	39.5 ±5 %		1.67±5%	
2450	39.2 ±5 %	PASS	1.80±5%	PASS
2600	39.0 ±5 %		1.96±5%	
3000	38.5 ±5 %		2.40 ±5 %	
3500	37.9 ±5 %		2.91 ±5 %	

### 7.2 SAR MEASUREMENT RESULT WITH HEAD LIQUID

The IEEE Std. 1528 and CEI/IEC 62209 standards state that the system validation measurements should produce the SAR values shown below (for phantom thickness of 2 mm), within the uncertainty for the system validation. All SAR values are normalized to 1 W forward power. In bracket, the measured SAR is given with the used input power.

Software	OPENSAR V4		
Phantom	SN 20/09 SAM71		
Probe	SN 18/11 EPG122		
Liquid	Head Liquid Values: eps' : 38.9 sigma : 1.79		
Distance between dipole center and liquid	10.0 mm		
Area scan resolution	dx=8mm/dy=8mm		
Zoon Scan Resolution	dx=5mm/dy=5m/dz=5mm		
Frequency	2450 MHz		
Input power	20 dBm		
Liquid Temperature	21 °C		
Lab Temperature	21 °C		
Lab Humidity	45 %		

Frequency MHz	1 g SAR (W/kg/W)		10 g SAR (W/kg/W)	
	required	measured	required	measured
300	2.85		1.94	0
450	4.58		3.06	
750	8.49		5.55	

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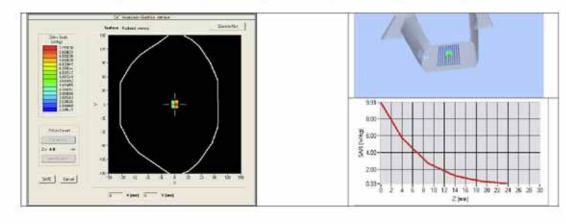


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#### SAR REFERENCE DIPOLE CALIBRATION REPORT

Ref: ACR.92.8.15.SATU.A

835	9.56		6.22	
900	10.9		6.99	
1450	29		16	
1500	30.5		16.8	
1640	34.2		18.4	
1750	36.4		19.3	
1800	38.4		20.1	
1900	39.7		20.5	
1950	40.5		20.9	
2000	41.1		21.1	
2100	43.6		21.9	
2300	48.7		23.3	
2450	52.4	53.38 (5.34)	24	24.20 (2.42)
2600	55.3		24.6	
3000	63.8		25.7	
3500	67.1		25	



#### 7.3 BODY LIQUID MEASUREMENT

Frequency MHz	Relative permittivity (s,')		Conductivity (a) S/m	
	required	measured	required	measured
150	61.9 ±5 %		0.80±5%	
300	58.2 ±5 %		0.92 ±5 %	
450	56.7 ±5 %		0.94 ±5 %	
750	55.5 ±5 %		0.96±5%	
835	55.2 ±5 %		0.97 ±5 %	
900	55.0 ±5 %		1.05±5%	
915	55.0 ±5 %		1.06 ±5 %	

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1450	54.0 ±5 %		1.30±5 %	
1610	53.8 ±5 %		1.40±5%	
1800	53.3 ±5 %		1.52±5%	
1900	53.3 ±5 %		1.52 ±5 %	
2000	53.3 ±5 %		1.52±5%	
2100	53.2 ±5 %		1.62±5%	
2450	52.7 ±5 %	PASS	1.95±5%	PASS
2600	52.5 ±5 %		2.16±5%	
3000	52.0 ±5 %		2.73±5%	
3500	51.3 ±5 %		3.31±5%	
5200	49.0 ±10 %		5.30±10%	
5300	48.9 ±10 %		5.42 ±10 %	
5400	48.7 ±10 %		5.53 ±10 %	
5500	48.6 ±10 %		5.65 ±10 %	
5600	48.5 ±10 %		5.77 ±10 %	
5800	48.2 ±10 %		6.00 ±10 %	

#### 7.4 SAR MEASUREMENT RESULT WITH BODY LIQUID

Software	OPENSAR V4		
Phantom	SN 20/09 SAM71		
Probe	SN 18/11 EPG122		
Liquid	Body Liquid Values: eps' : 52.7 sigma : 1.94		
Distance between dipole center and liquid	10.0 mm		
Area scan resolution	dx=8mm/dy=8mm		
Zoon Scan Resolution	dx=5mm/dy=5m/dz=5mm		
Frequency	2450 MHz		
Input power	20 dBm		
Liquid Temperature	21 °C		
Lab Temperature	21 °C		
Lab Humidity	45 %		

Frequency MHz	1 g SAR (W/kg/W)	10 g SAR (W/kg/W)	
	measured	measured	
2450	50.67 (5.07)	23.38 (2.34)	

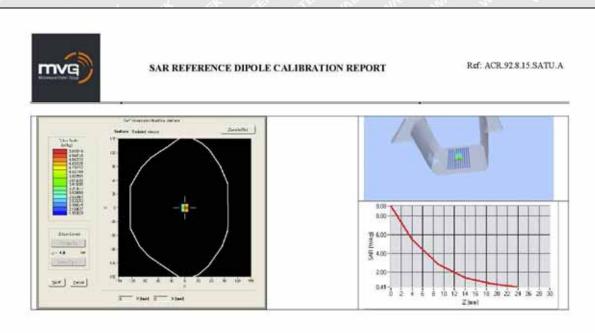
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# 8 LIST OF EQUIPMENT

Equipment Description	Manufacturer / Model	Identification No.	Current	Next Calibration	
			Calibration Date	Date	
SAM Phantom	MVG	SN-20/09-SAM71	Validated. No cal required.	Validated. No ca required.	
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No ca required.	
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2013	02/2016	
Calipers	Carrera	CALIPER-01	12/2013	12/2016	
Reference Probe	MVG	EPG122 SN 18/11	10/2014	10/2015	
Multimeter	Keithley 2000	1188656	12/2013	12/2016	
Signal Generator	Agilent E4438C	MY49070581	12/2013	12/2016	
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required	
Power Meter	HP E4418A	US38261498	12/2013	12/2016	
Power Sensor	HP ECP-E26A	US37181460	12/2013	12/2016	
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required	
Temperature and Humidity Sensor	Control Company	11-661-9	8/2012	8/2015	

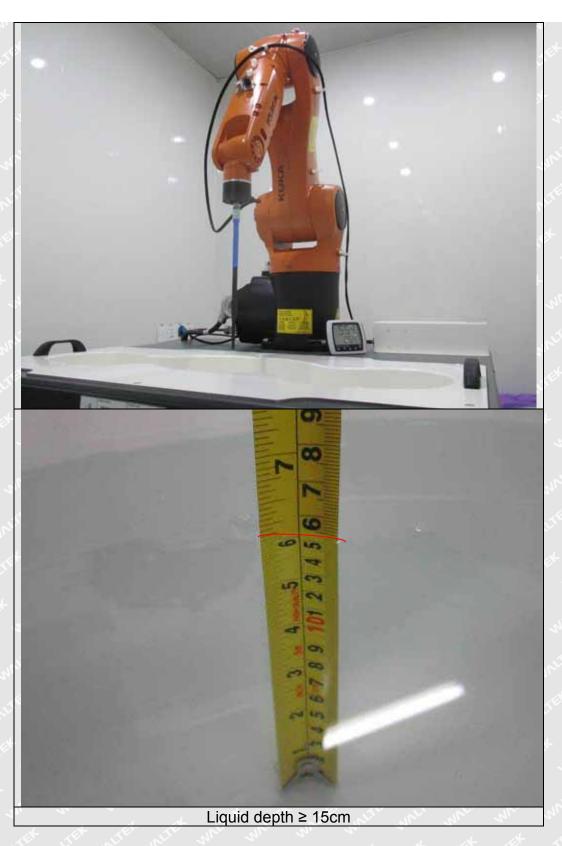
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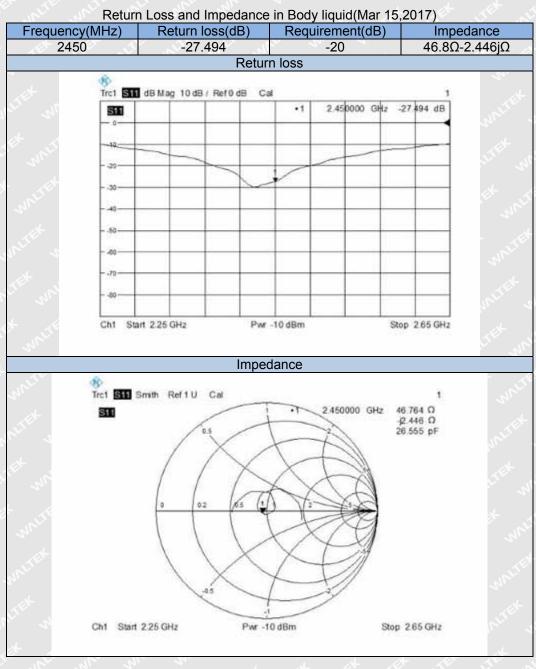
# 16 SAR System Photos



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# 17 <u>Re-calibration for Dipole</u>



17.1 DIPOLE 2450 (SN 09/15 DIP 2G450-363)

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# 18 Setup Photos





# 19 EUT Photos

**Front side** 



Back side



=====End of Report======

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